# UNISONIC TECHNOLOGIES CO., LTD

7NM64 **Power MOSFET Preliminary** 

# **5.0A, 640V N-CHANNEL** SUPER-JUNCTION MOSFET

## **DESCRIPTION**

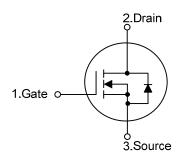
The UTC 7NM64 is an Super Junction MOSFET Structure. It uses UTC advanced planar stripe, DMOS technology to provide customers perfect switching performance, minimal on-state resistance.

The UTC 7NM64 is universally applied in electronic lamp ballasts based on half bridge topology, high efficiency switched mode power supplies, active power factor correction, etc.

# **FEATURES**

- \* Low drain-source on-resistance:  $R_{DS(ON)} < 0.95 \Omega$  (max.) by using Super Junction Structure
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

#### **SYMBOL**



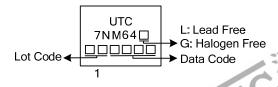
#### **ORDERING INFORMATION**

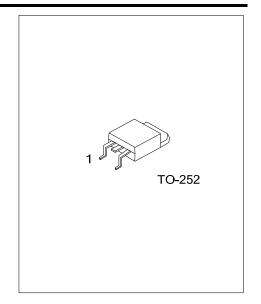
Ordering Number		Dookona	Pin Assignment			Daakina	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7NM64L-TN3-R	7NM64G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



#### **MARKING**





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# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	640	V	
Gate-Source Voltage		$V_{GSS}$	±25	V	
Avalanche Current (Note 2)		I <sub>AR</sub>	2	Α	
Drain Current	Continuous	I <sub>D</sub>	5	Α	
	Pulsed (Note 2)	I <sub>DM</sub>	20	Α	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	35	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.0	V/ns	
Power Dissipation		$P_{D}$	60	W	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 30mH,  $I_{AS}$  = 1.5A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C
- 4. I<sub>SD</sub>≤5A, di/dt≤200A/µs, V<sub>DD</sub>≤BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C

#### **■ THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	$\theta_{JC}$	2.08	°C/W	

Note: When mounted on 1 inch2 FR-4, 2 Oz copper board.



# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> =25°C, unless otherwise specified)

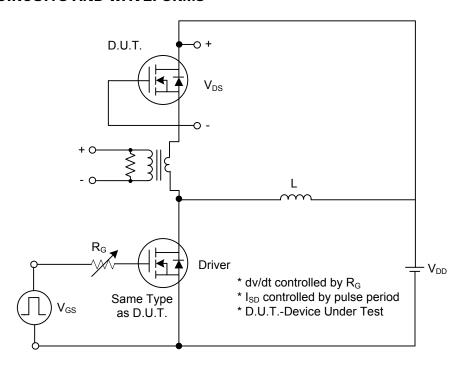
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	$V_{GS} = 0V, I_{D} = 250\mu A$	640			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> = 640V, V <sub>GS</sub> = 0V			1	μA
Gate- Source Leakage Current	Forward	less	V <sub>GS</sub> = 20V, V <sub>DS</sub> = 0V			100	nA
	Reverse		V <sub>GS</sub> = -20V, V <sub>DS</sub> = 0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	$V_{GS} = 10V, I_D = 2.5A$			0.95	Ω
DYNAMIC CHARACTERISTICS				_	_	_	
Input Capacitance	Capacitance C <sub>ISS</sub>			250		pF	
Output Capacitance		Coss	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0 MHz		180		pF
Reverse Transfer Capacitance	Reverse Transfer Capacitance				20		pF
SWITCHING CHARACTERISTICS	S			-	=.	-	
Total Gate Charge		$Q_G$	\/ -F0\/ \/ -10\/   -1.2A		40		nC
Gate-Source Charge		$Q_GS$	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =1.3A, I <sub>D</sub> =100µA (Note 1, 2)		4.2		nC
Gate-Drain Charge		$Q_GD$	ID-100μA (Note 1, 2)		11.5		nC
Turn-On Delay Time		$t_{D(ON)}$			45		ns
Turn-On Rise Time		$t_R$	V <sub>DS</sub> =30V, V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A,		90		ns
Turn-Off Delay Time		$t_{D(OFF)}$	R <sub>G</sub> =25Ω (Note 1, 2)		190		ns
Turn-Off Fall Time		$t_{F}$			70		ns
DRAIN-SOURCE DIODE CHARA	CTERISTIC	S AND MAXII	MUM RATINGS				
Maximum Continuous Drain-Source Diode		Is				5	Α
Forward Current						5	A
Maximum Pulsed Drain-Source Diode		I <sub>SM</sub>				20	Α
Forward Current						20	^
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>S</sub> =5.0A, V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time		$t_{RR}$	I <sub>S</sub> =5.0A, V <sub>GS</sub> =0V		470		ns
Body Diode Reverse Recovery Charge		$Q_{RR}$	dI/dt=100A/μs		4.6		μC

Notes: 1. Pulse Test: Pulse width≤300µs, Duty cycle≤2%.

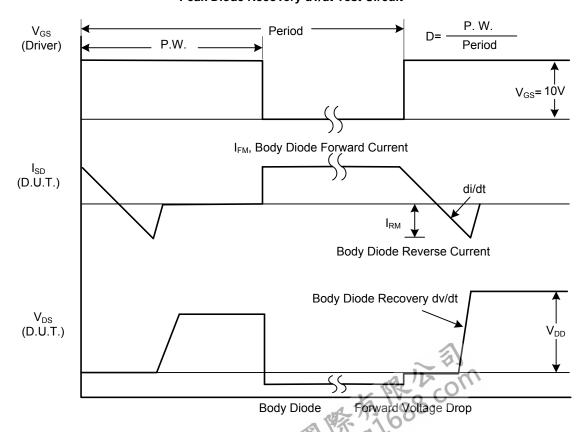


<sup>2.</sup> Essentially independent of operating temperature.

#### **■ TEST CIRCUITS AND WAVEFORMS**

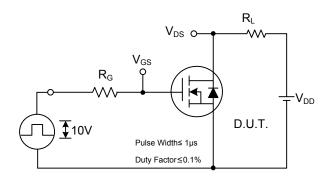


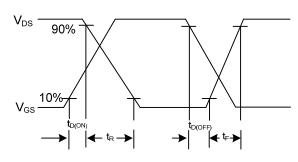
## Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dwdt Waveforms

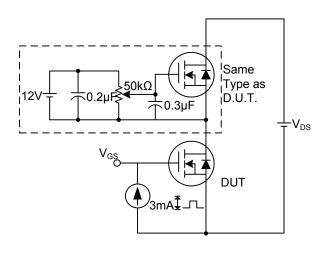
# **TEST CIRCUITS AND WAVEFORMS (Cont.)**

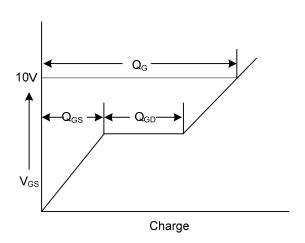




**Switching Test Circuit** 

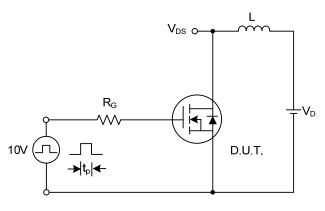
**Switching Waveforms** 

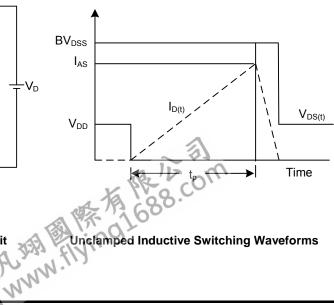




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

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